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Screened-Exchange Range-Separated Hybrid Functionals for heterogeneous systems

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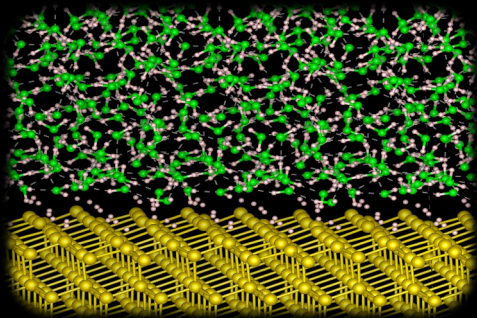
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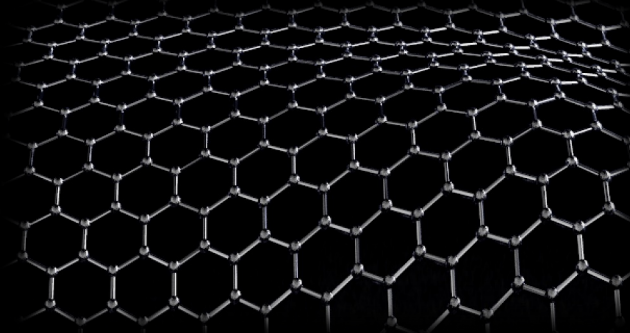
⁴*Department of Chemistry, University of Chicago*

March 4, 2024

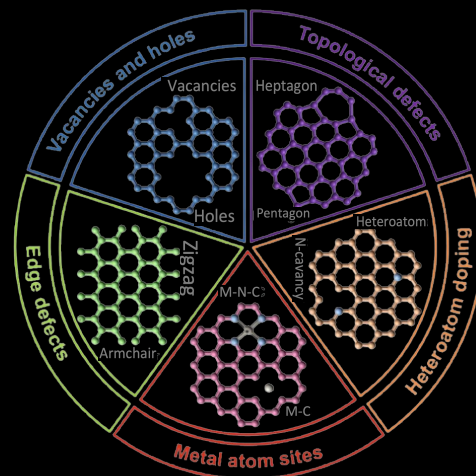
- **Materials** used in devices for the development of any technology exhibit inherent **heterogeneity**



interfaces

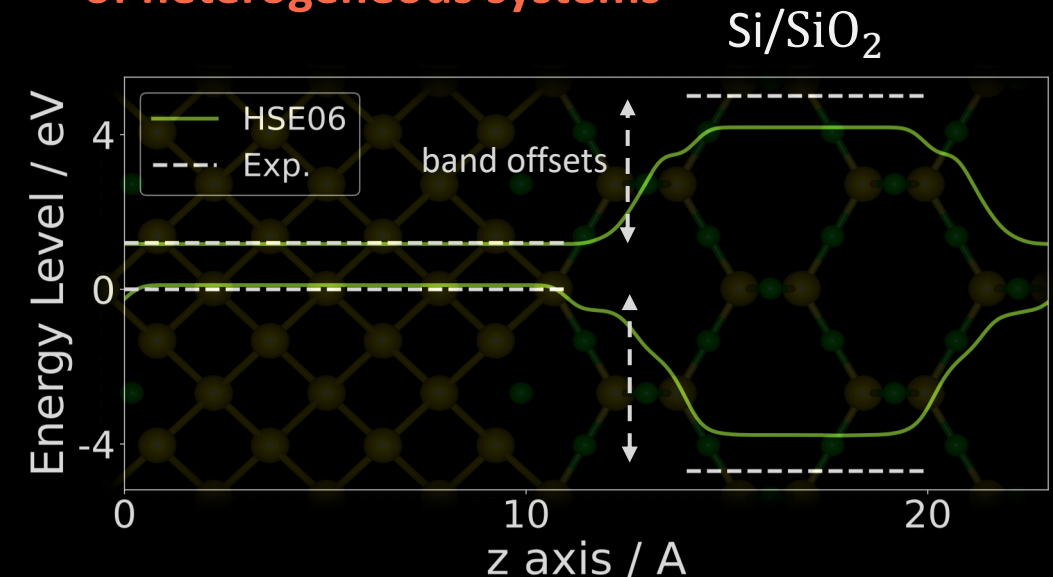


2D systems



defective systems

- **Density Functional Theory (DFT)** has been widely and successfully used for decades to provide insight into the mechanisms that govern the behavior of materials
- However, it is still **challenging** for available exchange and correlation (xc) functionals to **describe with the same accuracy** the electronic properties of **different components of heterogeneous systems**



- Introduction to Screened-Exchange Range-Separated Hybrid (SE-RSH)
- Applications of SE-RSH to
 - analyze the electronic structures of heterogeneous systems:
 - Interfaces
 - Two-dimensional (2D) systems
 - Defective 2D systems
 - metal oxides
- Conclusions and future work

F. Gygi, *Ibm J Res Dev* **52**, 137 (2008)



Family of Dielectric-Dependent Hybrid:

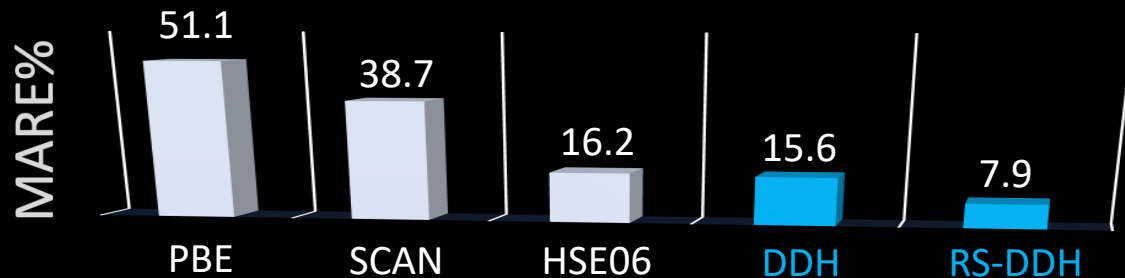
Global Dielectric-Dependent Hybrid (DDH)^[1]

$$\alpha = \frac{1}{\epsilon_{\infty}^{\text{bulk}}}$$

Range-Separated Dielectric-Dependent Hybrid (RS-DDH)^{[2][3]}

$$\alpha(\mathbf{r}, \mathbf{r}'; \frac{1}{\epsilon_{\infty}^{\text{bulk}}}, 1, \mu) = \frac{1}{\epsilon_{\infty}^{\text{bulk}}} + \left(1 - \frac{1}{\epsilon_{\infty}^{\text{bulk}}}\right) \text{erfc}(\mu|\mathbf{r} - \mathbf{r}'|)$$

Mean Average Relative Error [MARE%] for computed band gaps of semiconductors & insulators^[3]



Introduce spatial dependency into dielectric screening^[4-5]

Local dielectric function $\epsilon(\mathbf{r})$ via finite field method:

$$\Delta P(\mathbf{r}) = -e \sum_{i=1}^{N_w} \Delta \mathbf{r}_{wc}^i \delta(\mathbf{r} - \mathbf{r}_{wc}^i)$$
$$\epsilon_{\alpha\beta}(\mathbf{r}) = \delta_{\alpha\beta} + 4\pi \frac{\Delta P_{\alpha}(\mathbf{r})}{\Delta E_{\beta}(\mathbf{r})}$$

[1] J. H. Skone, M. Govoni, and G. Galli, Phys Rev B 89, 195112 (2014)

[2] W. Chen et al., Phys Rev Mater 2, 073803 (2018)

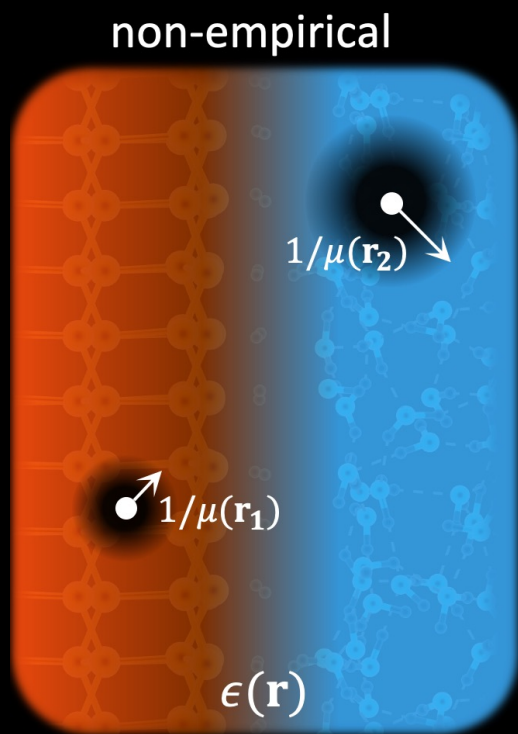
[3] J. H. Skone, M. Govoni, and G. Galli, Phys Rev B 93, 235106 (2016)

[4] H. Zheng, M. Govoni, and G. Galli, Phys Rev Mater 3, 073803 (2019)

[5] P. Borlido, M. A. L. Marques, and S. Botti, J Chem Theory Comput 14, 939 (2018)

The **ratio** of Fock exchange to semi-local depends on position:

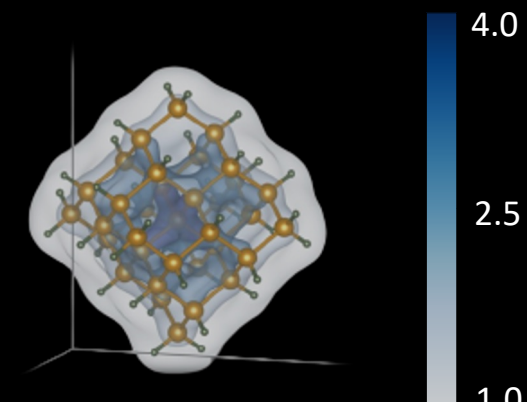
$$\alpha^{\text{SE-RSH}}(\mathbf{r}, \mathbf{r}'; \epsilon(\mathbf{r}), \mu(\mathbf{r})) = \underbrace{\frac{1}{\sqrt{\epsilon(\mathbf{r})\epsilon(\mathbf{r}')}}}_{\text{long-range screening}} + \underbrace{\left(1 - \frac{1}{\sqrt{\epsilon(\mathbf{r})\epsilon(\mathbf{r}')}}\right) \text{erfc}(\mu(\mathbf{r})\mathbf{r}_{12})}_{\text{short-range screening}}$$



SE-RSH



Local dielectric function $\epsilon(\mathbf{r})$



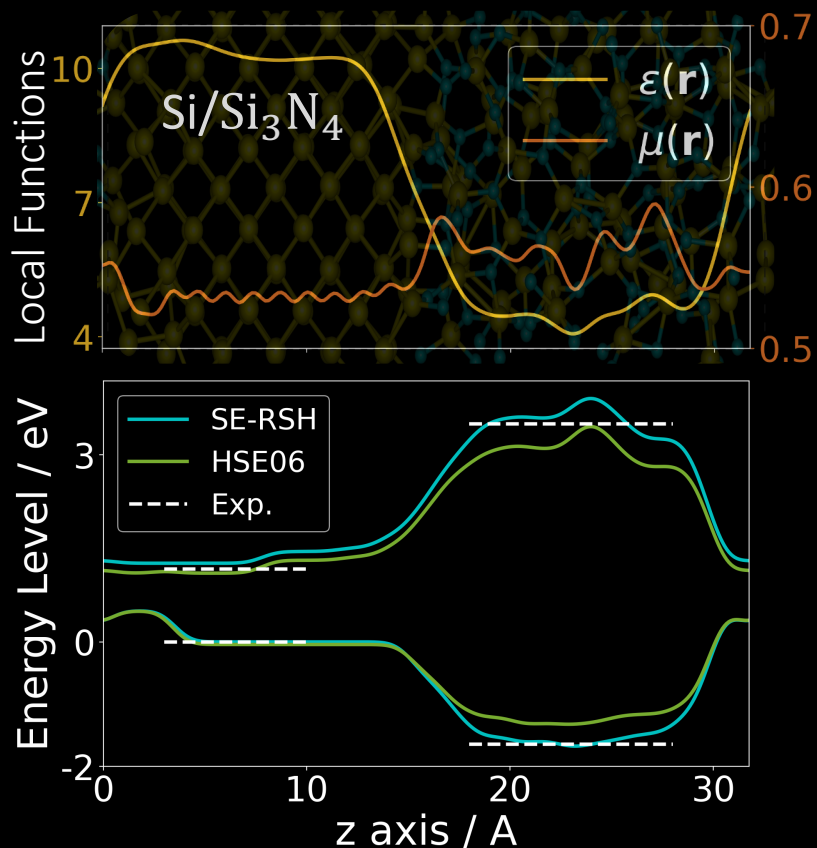
Finite-field@PBE

Local screening parameter $\mu(\mathbf{r})$

$$\mu(\mathbf{r}) = \frac{1}{2}k_{\text{TF}} = \left(\frac{3\rho(\mathbf{r})}{\pi}\right)^{1/6}$$

SE-RSH **generalizes** the definition of RS-DDH by introducing a **spatially dependent dielectric screening**.

Band offset at interfaces

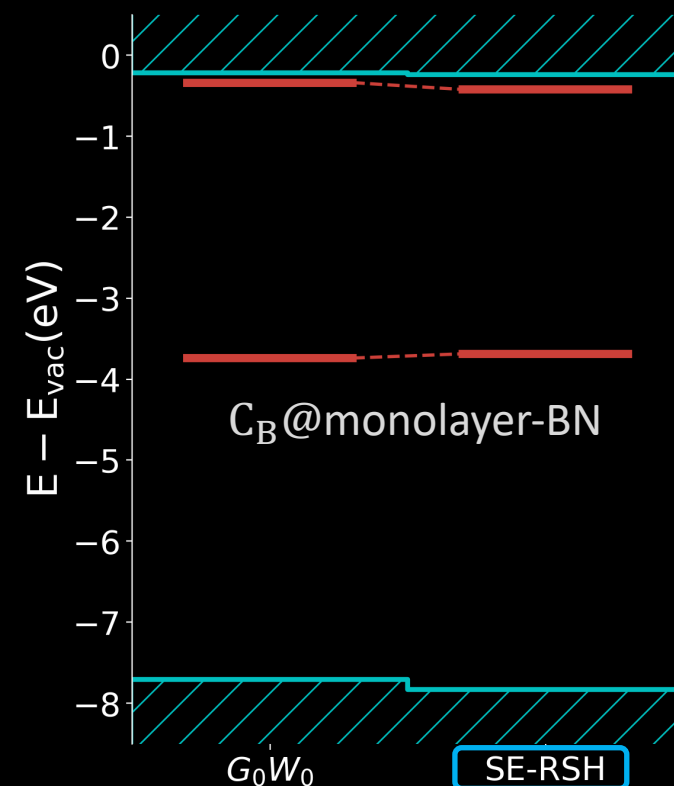


band gap (eV) of 2D systems

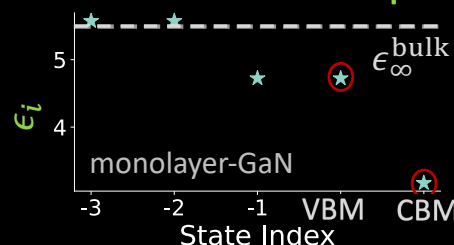
systems*	HSE06	SE-RSH	G ₀ W ₀ [Ref.]
phosphorene	1.50	2.07	2.00 [2]
MoS ₂	2.17	2.63	2.58 [3]
GaN	3.53	4.41	4.44 [1]
...
BN	5.7	7.59	7.49 [4]
MAE(eV)	1.28	0.21	
MARE(%)	29.4	6.4	

* A total of 9 2D systems were tested

Defects in 2D systems



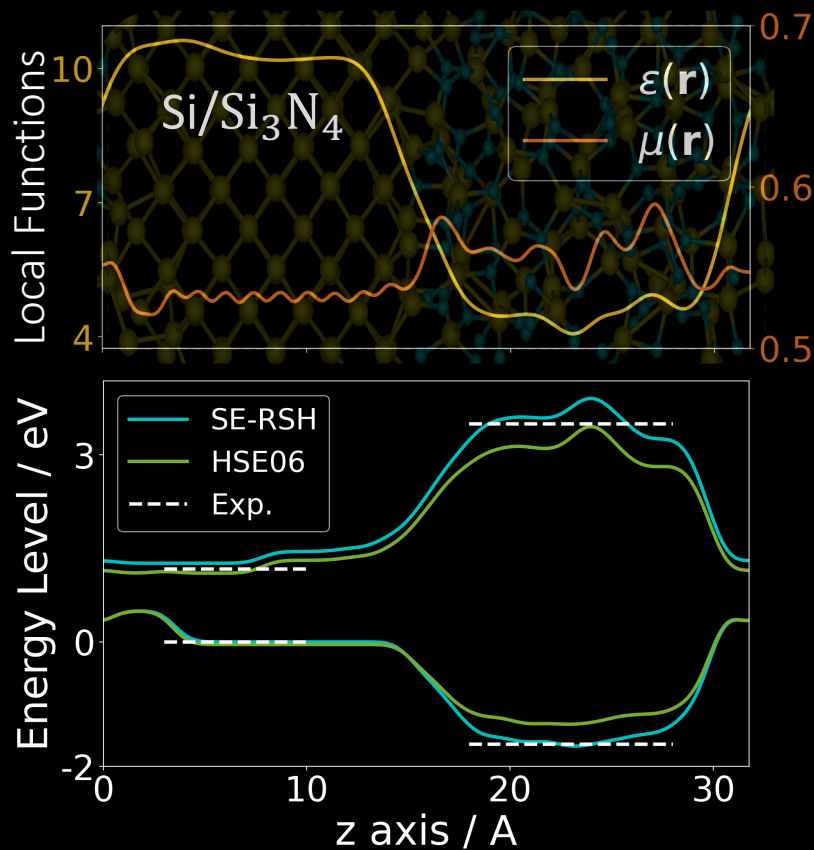
State-dependent screening



$$\epsilon_i = \int \epsilon(\mathbf{r}) |\psi_i(\mathbf{r})|^2 d\mathbf{r}$$



Band offset at interfaces

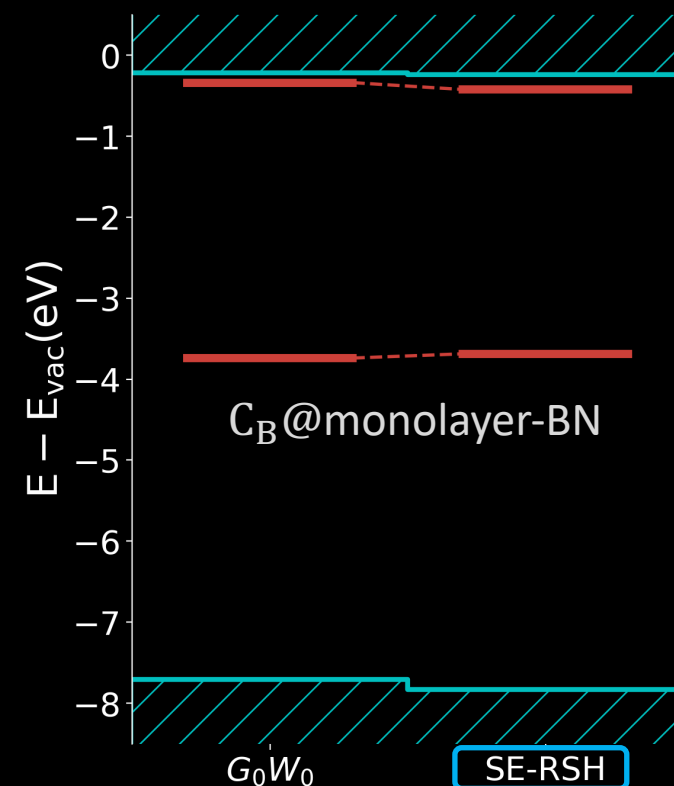


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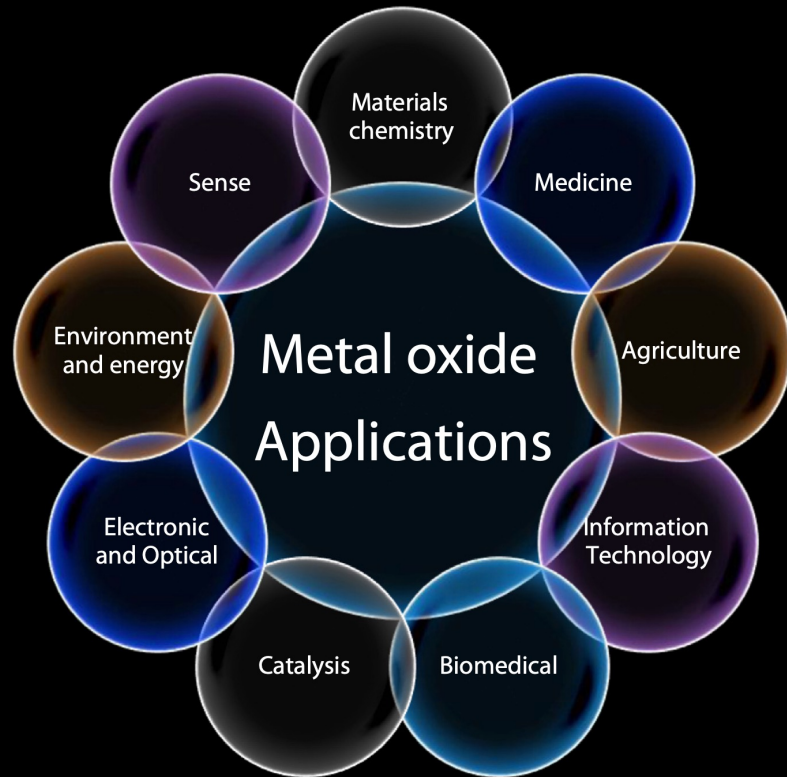
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Defects in 2D systems



SE-RSH is a **nonempirical hybrid functional** that enable accurate calculations of the electronic properties of heterogeneous systems.

- **Applications of metal oxides** are found in a wide range of fields.



Dielectric-Dependent Hybrid functionals tends to **overestimate** the bandgap of metal oxide.

systems	DD-RSH-CAM* ^[1]	Exp. + ZPR
In ₂ O ₃	3.51	2.7 ~ 2.9 [2]
TiO ₂	4.18	3.65 ~ 3.95 [3]
MnO	4.93	3.9~4.1 [4]
CoO	5.61	2.6 [4]
NiO	6.34	4.0 ~ 4.3 [4]

*DD-RSH-CAM is a dielectric-dependent hybrid that achieve high accuracy in various semiconductors and insulators.

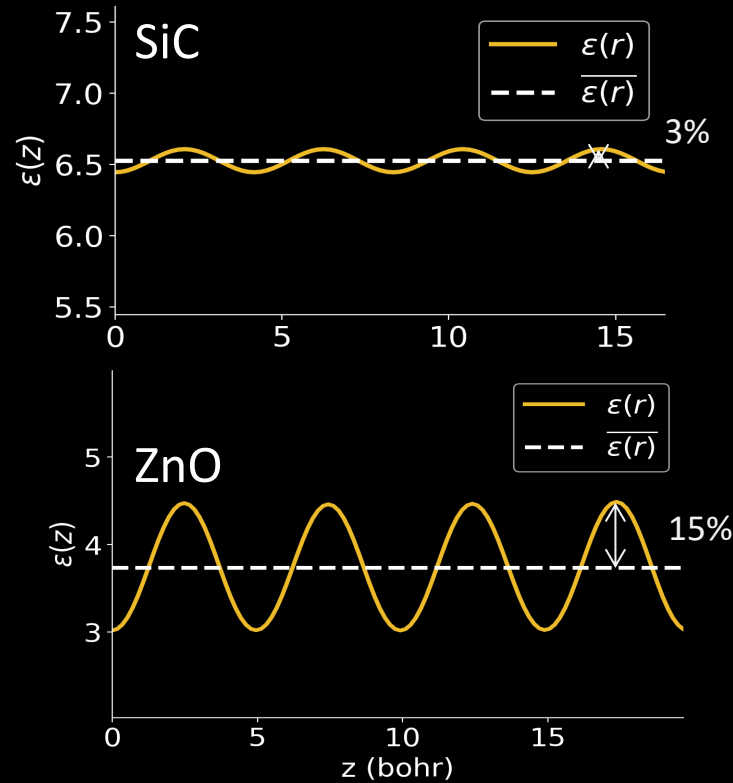
[1] Chen, Wei, et al. *Phys. Rev. Mater.* 2.7 (2018)

[2] Scherer, V., et al., *Appl. Phys. Lett.* 100.21 (2012)

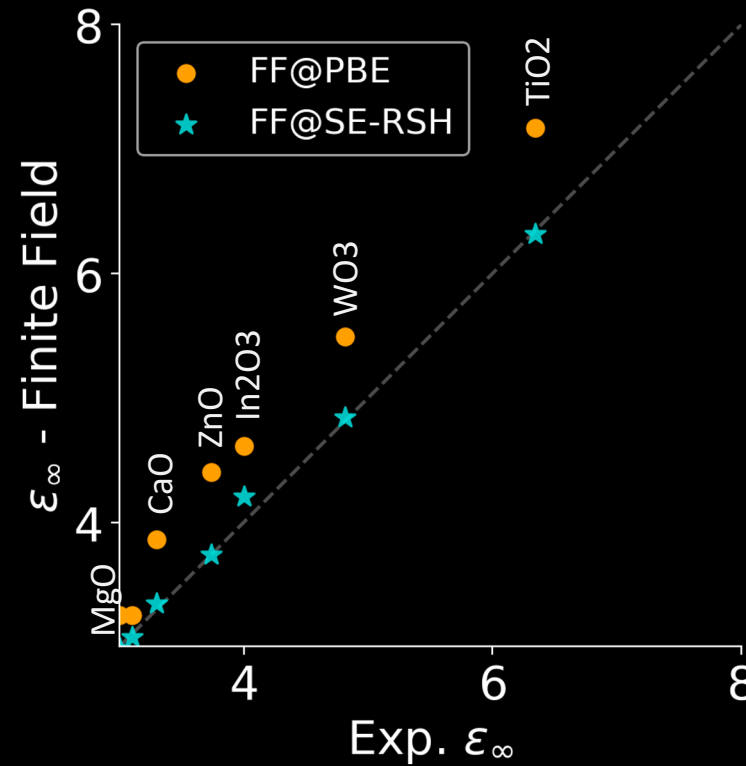
[3] Rangan, Sylvie, et al. *J. Phys. Chem. C.* 114.2 (2010)

[4] P. Liu et al., *J. Phys.: Condens. Matter.* 32, 015502 (2019)

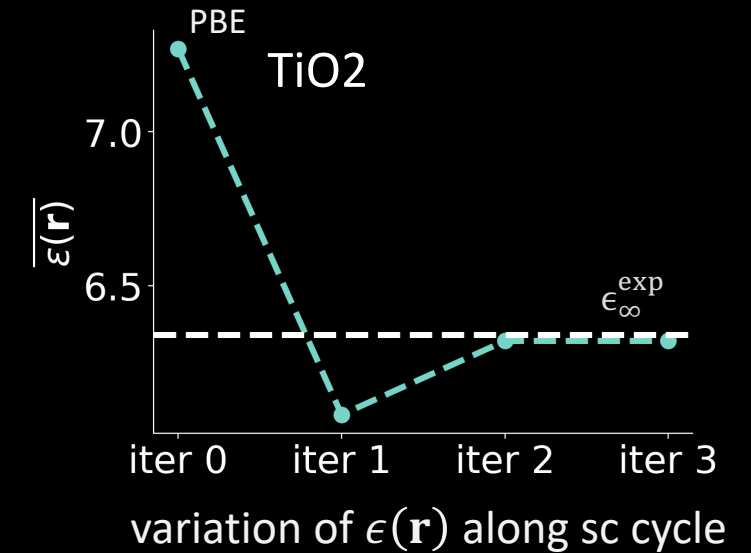
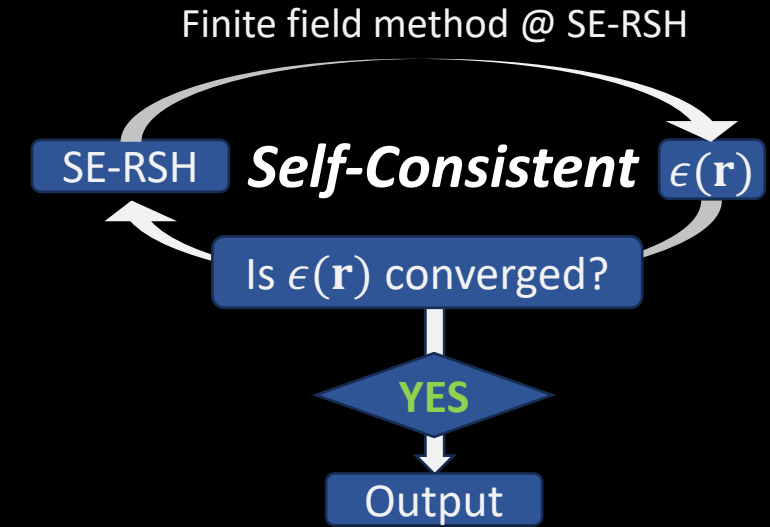
Challenges in applying DDH to metal oxides:



Marked spatial dependence of screening in ionic-bonded systems.



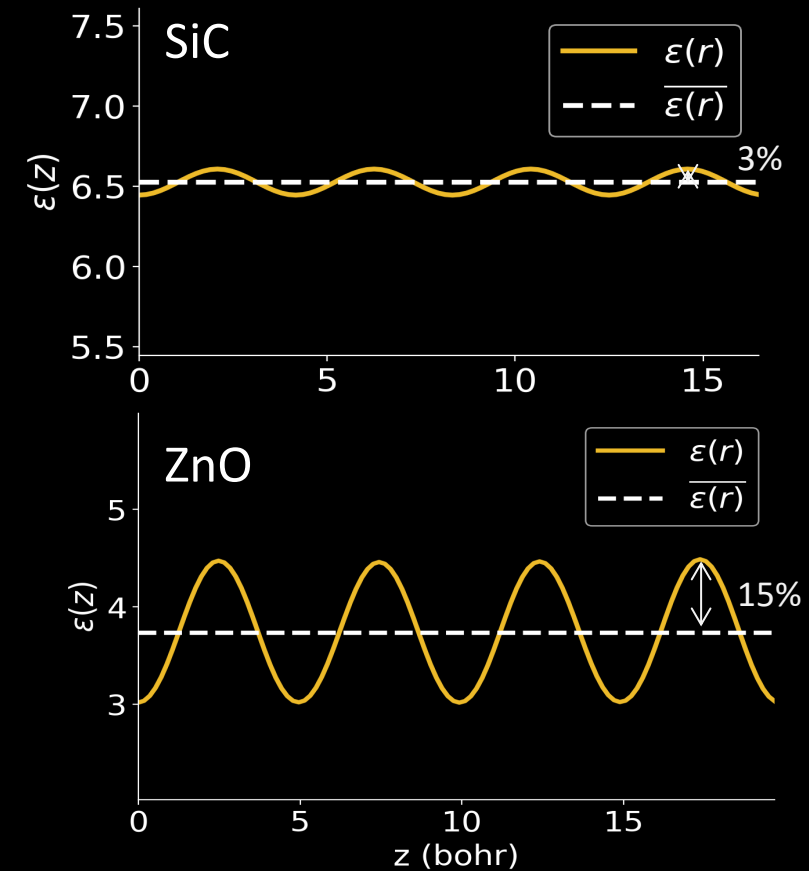
Calculation of ϵ @ PBE overestimates screening



Electronic band gap (eV) of metal oxides

systems*	DD-RSH-CAM _[1]	SE-RSH	Exp. + ZPR
In ₂ O ₃	3.51	2.99	2.7 ~ 2.9 [2]
TiO ₂	4.18	4.02	3.65 ~ 3.95 [3]
ZnO	3.74	3.56	3.61 [4]
Al ₂ O ₃	9.51	9.45	9.1 ~ 9.5 [5]
CaO	7.17	7.05	7.43 [6]
MgO	8.19	8.17	8.3 [7]
WO ₃	3.92	3.70	3.7 ~ 3.8 [8]
MAE(eV)	0.286	0.213	
MARE(%)	6.87	3.70	

- [1] Chen, Wei, et al. *Phys. Rev. Mater.* 2.7 (2018)
- [2] Scherer, V., et al., *Appl. Phys. Lett.* 100.21 (2012)
- [3] Rangan, Sylvie, et al. *J. Phys. Chem. C.* 114.2 (2010)
- [4] Reynolds, D. C., et al. *Phys. Rev. B* 60.4 (1999)
- [5] French, Roger H., *J. Am. Ceram. Soc.* 73.3 (1990)
- [6] Whited, R. C. et al. *Solid State Commun.* 13.11 (1973)
- [7] Onuma, Takeyoshi, et al. *Appl. Phys. Lett.* 119.13 (2021)
- [8] Meyer, Jens, et al. *Appl. Phys. Lett.* 96.19 (2010)

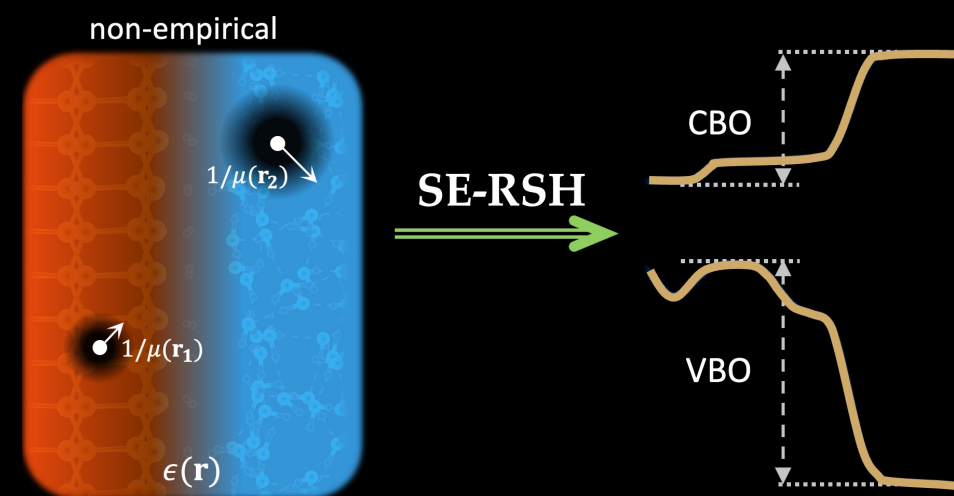


SE-RSH results appear to be more accurate than RSH results, due to the inclusion of the spatial variation of the screening.

We proposed a nonempirical range-separated hybrid functional with spatially dependent screened exchange, SE-RSH, enabling accurate calculations of the electronic properties of heterogeneous systems and metal oxides.

The validation of our results for diverse materials shows that:

1. **Utilization of local dielectric function $\epsilon(\mathbf{r})$** help SE-RSH achieve high accuracy.
2. **Metal oxides** exhibit a strong spatial variation of the screening, which is captured by **SE-RSH**.



Future Work

1. Study metal-oxide interfaces w/wo defects.
2. Integrate Time-Dependent Density Functional Theory (TDDFT) with SE-RSH.
3. Accelerate exact exchange calculations in SE-RSH for modeling large-scale complex systems.

Acknowledgement

The GALLI GROUP

@ The University of Chicago

$$\hbar \frac{\partial \psi}{\partial t} = -\frac{\hbar^2}{2m} \nabla^2 \psi + V \psi$$

$$\langle \psi | U | \psi \rangle = \sum_{n=1}^{\infty} \frac{|\langle m | U | n \rangle|^2}{\epsilon_n - \epsilon_m}$$



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$$\sum_j \langle ij | \alpha \odot v_c | ji \rangle \quad \text{vs.} \quad \sum_j \langle ij | \epsilon^{-1} v_c | ji \rangle$$

ϵ^{-1} : full dielectric matrix

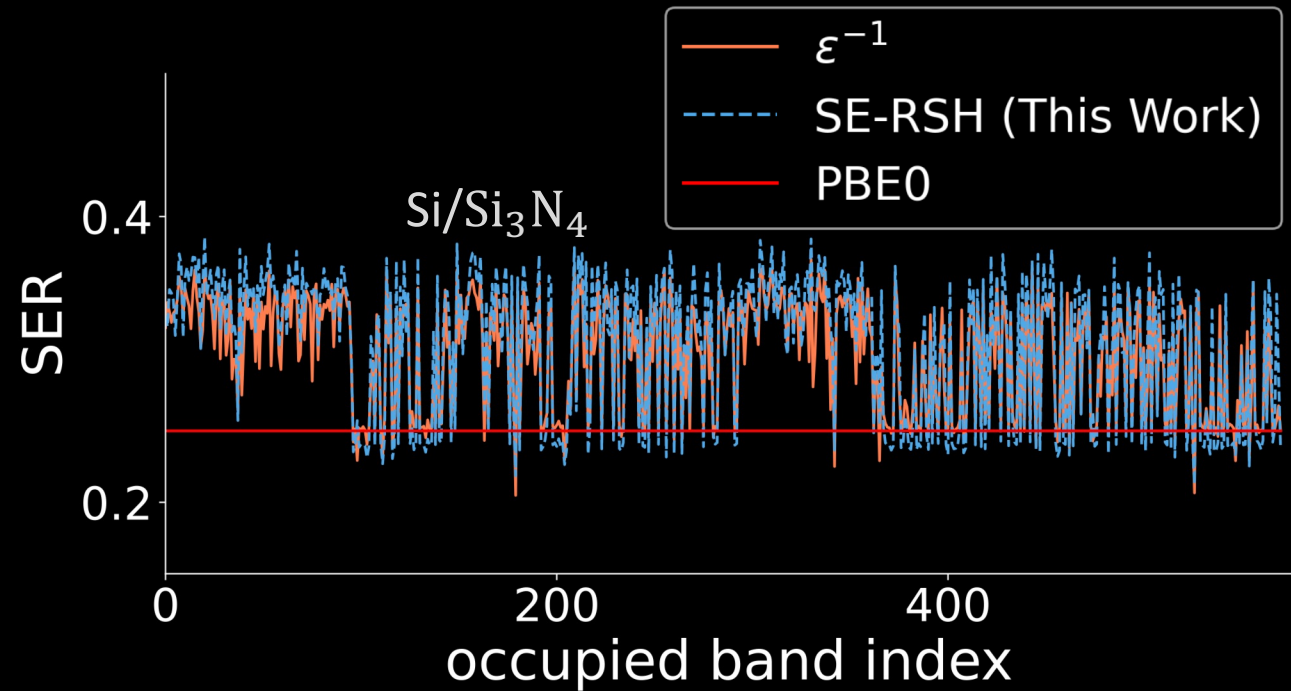
v_c : bare coulomb interaction

$\{|i\rangle\}$: Maximally Localized Wannier Functions

screened exchange ratio (SER):

$$\text{SER}_i^\alpha = \frac{\sum_j \langle ij | \alpha \odot v_c | ji \rangle}{\sum_j \langle ij | v_c | ji \rangle}$$

$$\text{SER}_i^{\epsilon^{-1}} = \frac{\sum_j \langle ij | \epsilon^{-1} v_c | ji \rangle}{\sum_j \langle ij | v_c | ji \rangle}$$



α^{SE-RSH} effectively approximates and accurately describes non-dynamical screening